

●General Description

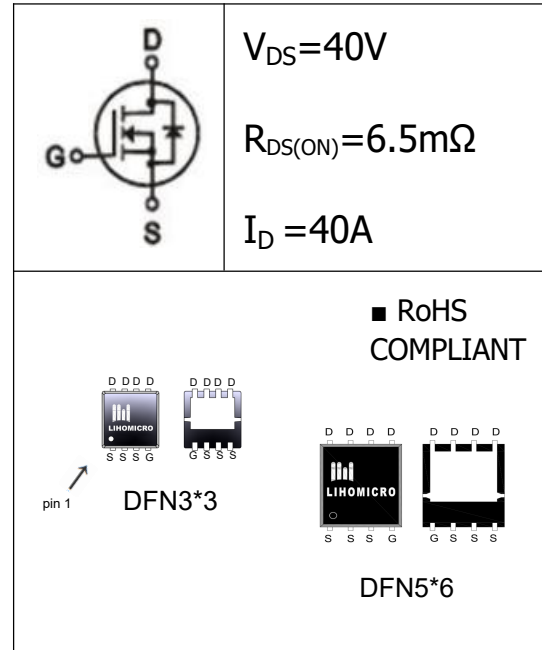
The MOSFET LH40N04 has the low $R_{DS(on)}$, low gate charge, fast switching and excellent avalanche characteristics. This device is suitable for fast charge and lighting.

●Features

- Fast switching
- Low $R_{DS(on)}$ to minimize conductive loss
- Advance high sell density trench technology
- 100% EAS Guaranteed

●Application

- LED/LCD/PDP TV and monitor Lighting
- Power Supplies
- PD Charger



●Ordering Information:

Part Number	LH40N04	LH40N04
Package	DFN3*3	DFN5*6
Basic Ordering Unit (pcs)	5000	5000
Normal Package Material Ordering Code	LH40N04D3-DFN3*3-TAP	LH40N04D-DFN5*6-TAP
Halogen Free Ordering Code	LH40N04D3-DFN3*3-TAP -HF	LH40N04D-DFN5*6-TAP-HF

●Absolute Maximum Ratings (TC =25℃)

PARAMETER	SYMBOL	Value	UNIT
Drain-Source Breakdown Voltage	BV_{DSS}	40	V
Gate-Source Voltage	V_{GS}	±20	V
Continuous Drain Current	$I_D @ T_C = 25^\circ C$	50	A
	$I_D @ T_C = 75^\circ C$	40	A
	$I_D @ T_C = 100^\circ C$	33	A
Pulsed drain current ¹	I_{DM}	125	A
Single Pulse Avalanche Energy ²	E_{AS}	67	mJ
Power Dissipation(TC=25℃)	P_D	40	W
Operating Temperature	T_J	-55~+150	℃
Storage Temperature	T_{STG}	-55~+150	℃

●Electronic Characteristics

PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	40	--	--	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.2	--	3.0	V
Drain-source On Resistance ³	$R_{DS(ON)}$	$V_{GS}=10V, I_D=20A$	--	6.5	8.5	mΩ
		$V_{GS}=4.5V, I_D=20A$	--	10	15	
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=40V, V_{GS}=0V, T_J=25^\circ C$	--	--	1	μA
		$V_{DS}=40V, V_{GS}=0V, T_J=85^\circ C$	--	--	10	
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	--	--	±100	nA
Input Capacitance	C_{iss}	$f = 1.0MHz$	--	690	--	pF
Output Capacitance	C_{oss}		--	195	--	
Reverse transfer Capacitance	C_{rss}		--	38	--	
Turn-On Delay Time	$T_d(on)$	$V_{DD}=20V$ $V_{GS}=10V$ $R_G=3.3\Omega$	--	14.3	--	nS
Rise Time	T_r		--	5.5	--	
Turn-Off Delay Time	$T_d(off)$		--	20	--	
Fall Time	T_f		--	12	--	
Total Gate Charge	Q_g	$I_D=20A,$ $V_{DD}=20V$ $V_{GS}=4.5V$	--	6	---	nC
Gate-to-Source Charge	Q_{gs}		--	3	--	
Gate-to-Drain Charge	Q_{gd}		--	1.5	---	
Continuous Diode Forward Current	I_S	--	--	--	40	A
Diode Forward Voltage	V_{SD}	$T_J=25^\circ C, I_S=20A$ $V_{GS}=0V$	--	--	1.2	V

●Thermal Characteristics

PARAMETER	SYMBOL	MAX	UNIT
Thermal Resistance Junction-case	R_{thJC}	3.2	°C/W
Thermal Resistance Junction-ambient	R_{thJA}	60	°C/W
Soldering temperature, wave soldering for 10s	T_{sld}	265	°C

Notes:

1.Repetitive Rating: Pulse width limited by maximum junction temperature.

2. $I_{AS}=30A, V_{DD}=20V, L=0.1mH, R_G=25\Omega$, Starting $T_J=25^\circ C$

3.Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$

• **Typical Characteristics**

Figure 1. Typ. output characteristics

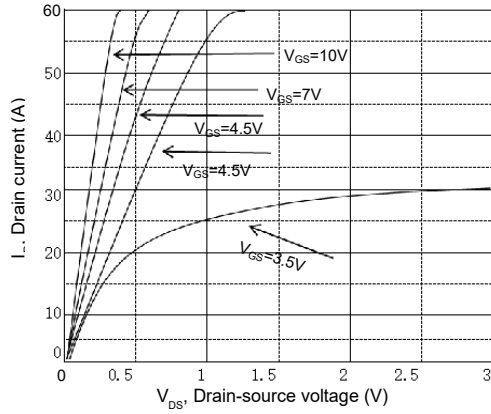


Figure 2. Typ. transfer characteristics

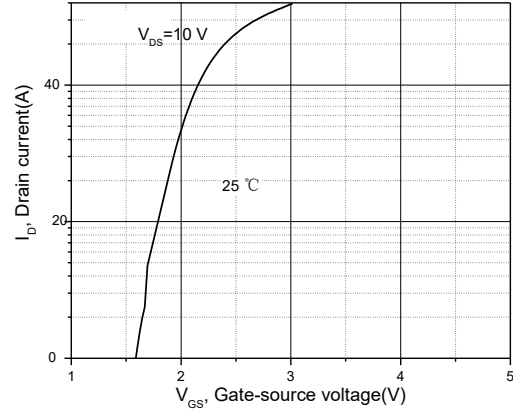


Figure 3. Typ. capacitances

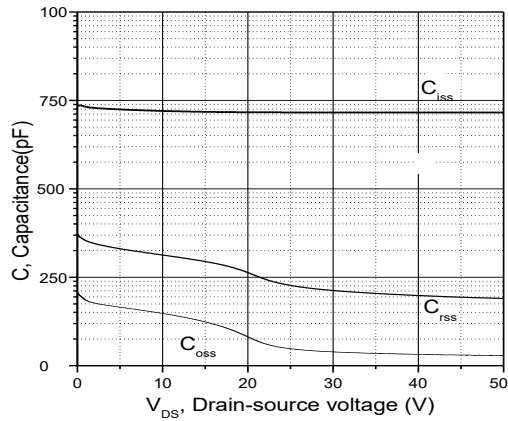


Figure 4. Typ. gate charge

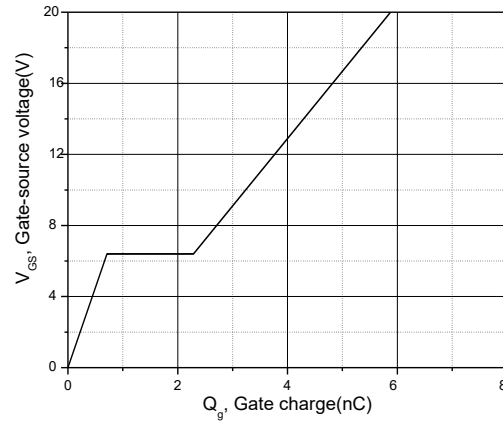


Figure 5. Source Drain Forward Characteristics

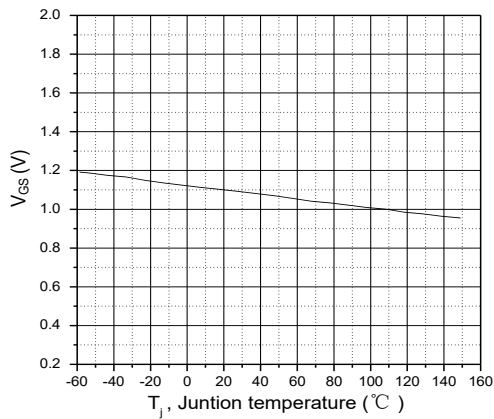
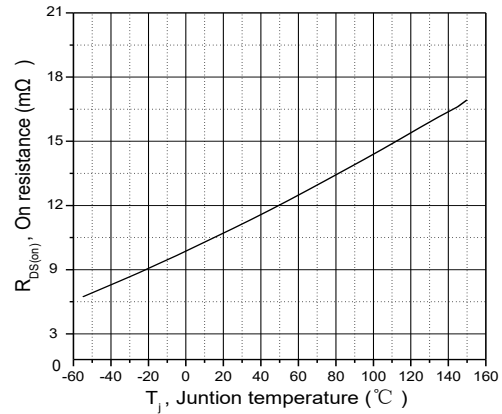


Figure 6. Drain-source on-state resistance



●Typical Characteristics(Cont.)

Figure 7. Forward characteristic of body diode

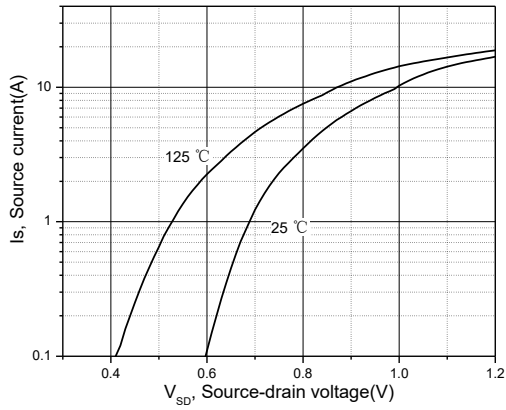


Figure 8. Drain-source on-state resistance

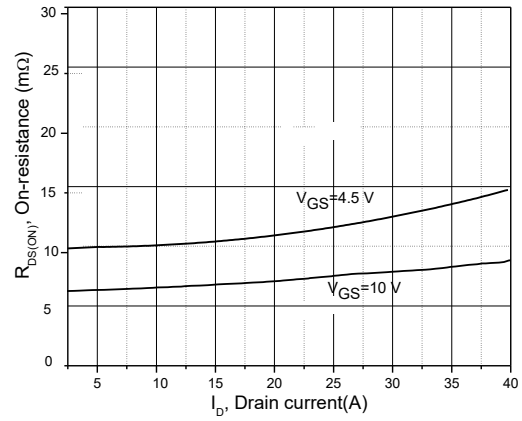


Figure 9. Safe operation area TC=25 °C

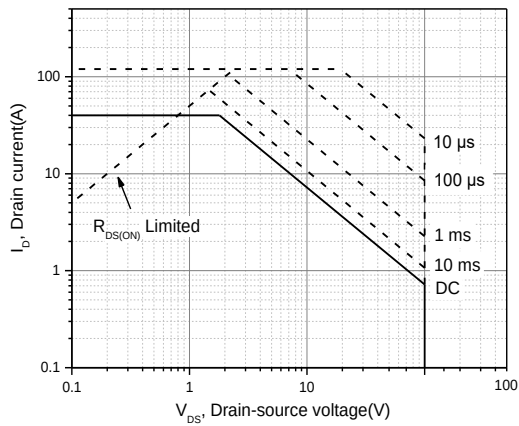
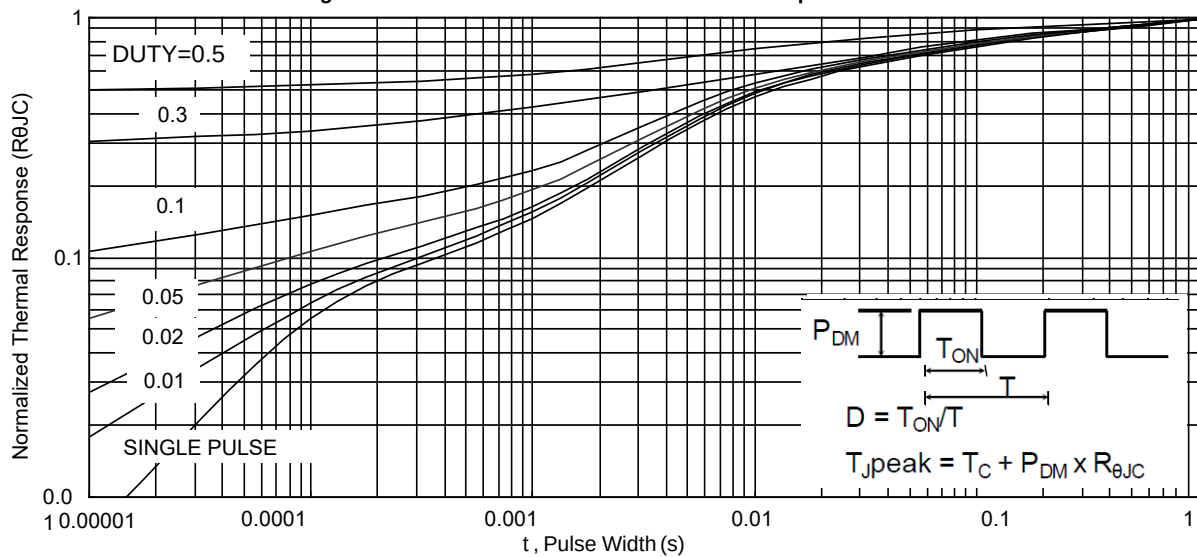


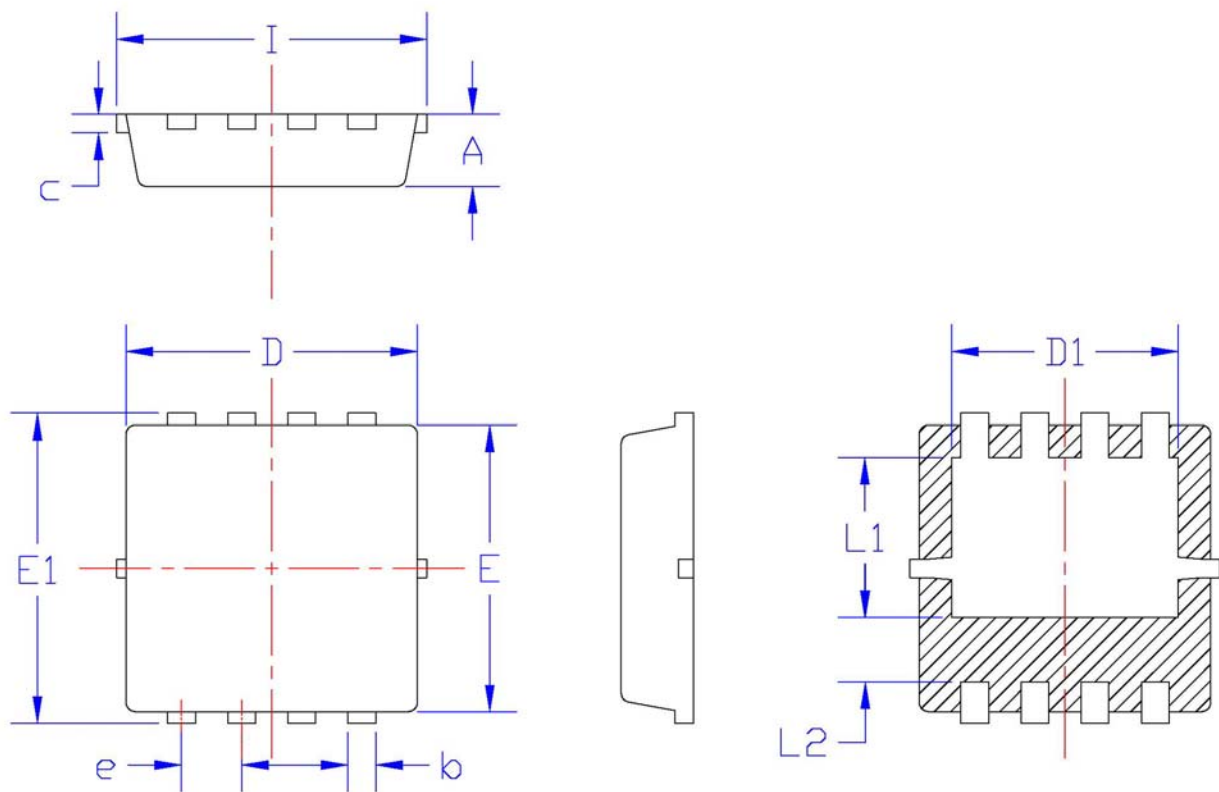
Fig.9 Normalized Maximum Transient Thermal Impedance



• **Dimensions (DFN3*3)**

Unit: mm

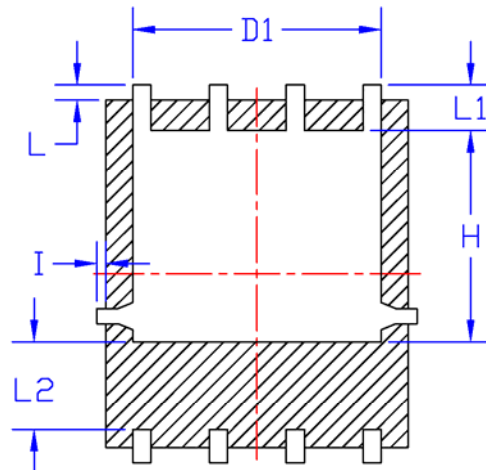
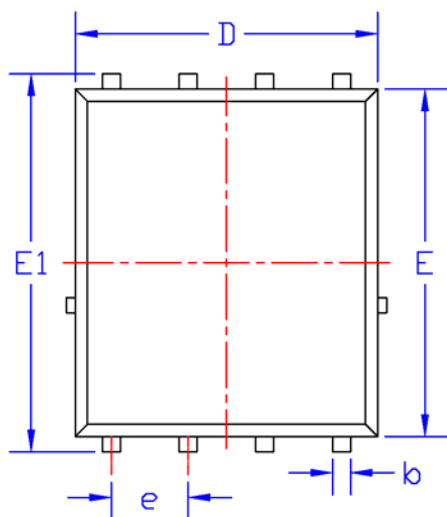
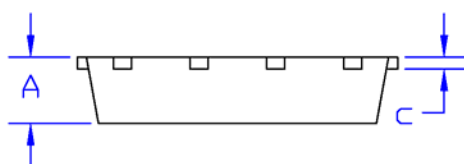
SYMBOL	min	max	SYMBOL	min	max
A	0.68	0.88	e	0.65BSC	
b	0.27	0.47	L1	1.55	1.95
c	0.15	0.35	L2	0.5	0.9
D	3.05	3.25	I	3.10	3.50
D1	2.25	2.65			
E	3.05	3.25			
E1	3.15	3.55			



●Dimensions (DFN5*6)

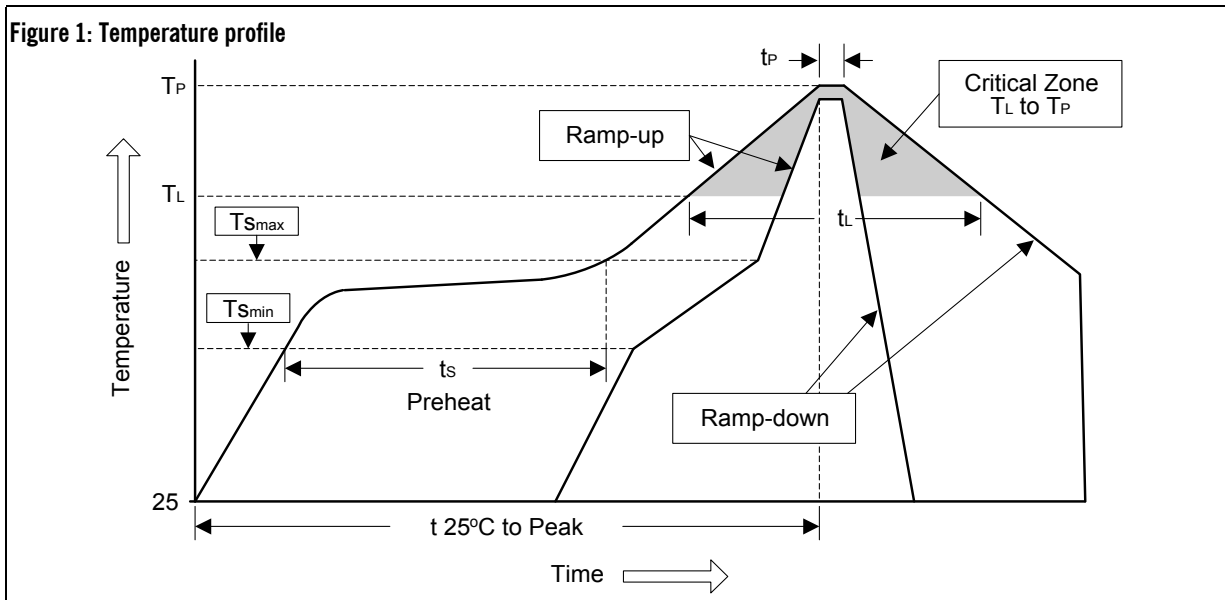
UNIT:mm

SYMBOL	min	max	SYMBOL	min	max
A	1.00	1.20	e	1.27BSC	
b	0.30	0.50	L	0.05	0.30
c	0.20	0.30	L1	0.40	0.80
D	4.80	5.20	L2	1.20	2.00
D1	3.90	4.30	H	3.30	3.80
E	5.50	5.90	I	—	0.18
E1	5.90	6.40			



• Soldering Methods for Silicongear's Products

1. Storage environment: Temperature=10°C to 35°C Humidity=65%±15%
2. Reflow soldering of surface-mount devices



Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (TL to TP)	<3°C/sec	<3°C/sec
Preheat		
- Temperature Min (Tsmmin)	100°C	150°C
- Temperature Max (Tsmmax)	150°C	200°C
- Time (min to max) (ts)	60 to 120 sec	60 to 180 sec
Tsmmax to TL		
- Ramp-up Rate	<3°C/sec	<3°C/sec
Time maintained above:		
- Temperature (TL)	183°C	217°C
- Time (tL)	60 to 150 sec	60 to 150 sec
Peak Temperature (TP)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (tp)	10 to 30 sec	20 to 40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25°C to Peak Temperature	<6 minutes	<8 minutes

3. Flow (wave) soldering (solder dipping)

Products	Peak Temperature	Dipping Time
Pb devices.	245°C ±5°C	5sec ±1sec
Pb-Free devices.	260°C +0/-5°C	5sec ±1sec